

# **FDW2501N**

# **Dual N-Channel 2.5V Specified PowerTrench** MOSFET

### **General Description**

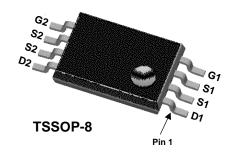
This N-Channel 2.5V specified MOSFET is a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (2.5V-12V).

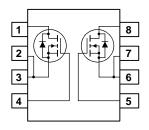
### **Applications**

- Load switch
- Motor drive
- DC/DC conversion
- · Power management

#### **Features**

- 6 A, 20 V.  $R_{DS(ON)} = 0.018 \ \Omega \ @ \ V_{GS} = 4.5 V$   $R_{DS(ON)} = 0.028 \ \Omega \ @ \ V_{GS} = 2.5 V$
- $\bullet~$  Extended  $V_{\text{GSS}}$  range (±12V) for battery applications.
- High performance trench technology for extremely low  $R_{\mbox{\scriptsize DS}(\mbox{\scriptsize ON})}$
- Low profile TSSOP-8 package





## Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		20	V
$V_{GSS}$	Gate-Source Voltage		±12	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	6	А
	– Pulsed		30	
P <sub>D</sub>	Power Dissipation	(Note 1a)	1.0	W
		(Note 1b)	0.6	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temp	erature Range	-55 to +150	°C

### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	125	°C/W
		(Note 1b)	208	

**Package Marking and Ordering Information** 

Device Marking	Device	Reel Size	Tape width	Quantity
2501N	FDW2501N	13"	12mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	20			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		12		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 16 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			1	μА
I <sub>GSS</sub>	Gate-Body Leakage	$V_{GS} = \pm 12 \text{ V},  V_{DS} = 0 \text{ V}$			±100	nA
On Char	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	0.4	0.9	1.5	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A$ , Referenced to $25^{\circ}C$		-3.2		mV/°0
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$\begin{split} &V_{GS} = 4.5 \text{ V}, & I_{D} = 6.0 \text{ A} \\ &V_{GS} = 2.5 \text{ V}, & I_{D} = 5.0 \text{ A} \\ &V_{GS} = 4.5 \text{ V}, I_{D} = 6.0 \text{A}, T_{J} = 125^{\circ} \text{C} \end{split}$		15.5 19.6 20	18 28 29	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = 4.5 \text{ V}, \qquad V_{DS} = 5 \text{ V}$	30			Α
<b>g</b> <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 \text{ V}, \qquad I_{D} = 6.0 \text{ A}$		32		S
Dvnamic	Characteristics			•		
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 10 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		1290		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		315		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			170		pF
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> = 15 mV, f = 1.0 MHz		2.0		Ω
Switchin	g Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 10 \text{ V}, \qquad I_{D} = 1 \text{ A},$		10	18	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		15	27	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	1		26	47	ns
t <sub>f</sub>	Turn-Off Fall Time			9.5	19	ns
Qg	Total Gate Charge	$V_{DS} = 10 \text{ V}, \qquad I_{D} = 6.0 \text{ A},$		12	17	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 4.5 V		2.4		nC
$Q_{gd}$	Gate-Drain Charge			3.3		nC
Drain-So	ource Diode Characteristics	and Maximum Ratings		_		
m	Diode Reverse Recovery Time	I <sub>F</sub> = 6.0 A,		20		nS
	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$		6.7		nC
I <sub>S</sub>	Maximum Continuous Drain–Source	e Diode Forward Current		İ	0.83	Α
V <sub>SD</sub>	Drain-Source Diode Forward	$V_{GS} = 0 \text{ V},  I_{S} = 0.83 \text{ A}  \text{(Note 2)}$		0.7	1.2	V

#### Notes

<sup>1.</sup>  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.

a)  $\rm\,R_{\rm \theta JA}$  is 125°C/W (steady state) when mounted on a 1 inch² copper pad on FR-4.

b) R<sub>0JA</sub> is 208°C/W (steady state) when mounted on a minimum copper pad on FR-4.

<sup>2.</sup> Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

# **Typical Characteristics**

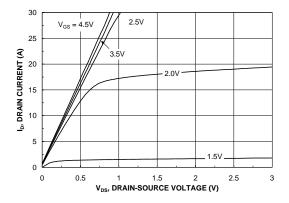


Figure 1. On-Region Characteristics.

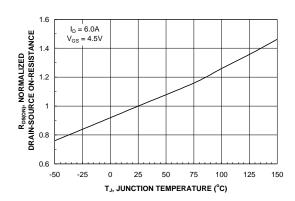


Figure 3. On-Resistance Variation with Temperature.

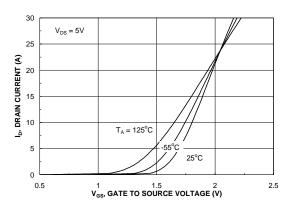


Figure 5. Transfer Characteristics.

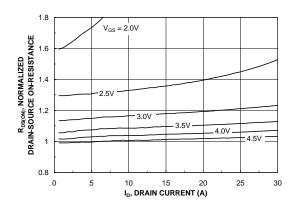


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

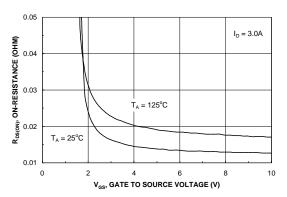


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

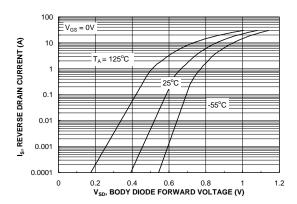
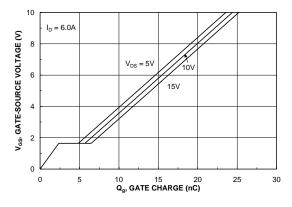


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

# **Typical Characteristics**



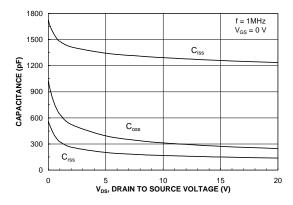
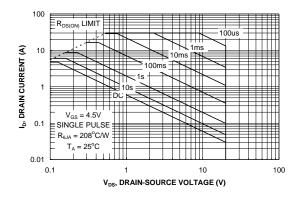


Figure 7. Gate Charge Characteristics.





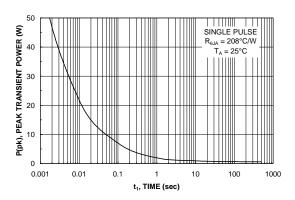


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

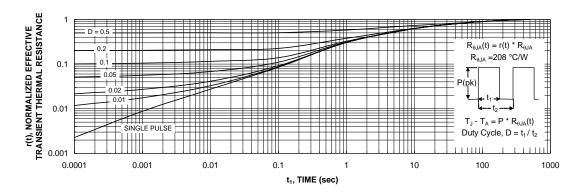


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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CROSSVOLT™	FRFET™	MicroPak™	QFET®	SuperSOT™-8
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